

| | | | |
|-----------------------------------|---------------------------------------|--|-------------|
| Notice of References Cited | Application/Control No. 10/710,700 | Applicant(s)/Patent Under Reexamination GRANT ET AL. | |
| | Examiner Lex Malsawma | Art Unit 2823 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|------------------|----------------|
| | A | US-3,769,104 | 10-1973 | Ono et al. | 117/106 |
| | B | US-4,603,059 | 07-1986 | Kiyosumi et al. | 438/396 |
| | C | US-4,687,682 | 08-1987 | Koze, Jeffrey T. | 438/471 |
| | D | US-4,925,809 | 05-1990 | Yoshiharu et al. | 117/106 |
| | E | US-5,121,705 | 06-1992 | Sugino, Masao | 118/719 |
| | F | US-5,296,385 | 03-1994 | Moslehi et al. | 438/514 |
| | G | US-5,571,333 | 11-1996 | Kanaya, Koichi | 118/724 |
| | H | US-6,448,180 B2 | 09-2002 | Mani et al. | 438/680 |
| | I | US-6,454,854 B1 | 09-2002 | Ose, Hiroki | 117/90 |
| | J | US-2003/0119288 A1 | 06-2003 | Yamazaki et al. | 438/565 |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.